



KEY PARTNER FOR ELECTROMAGNETISM



Antennes optiques RX

pour champ E et H



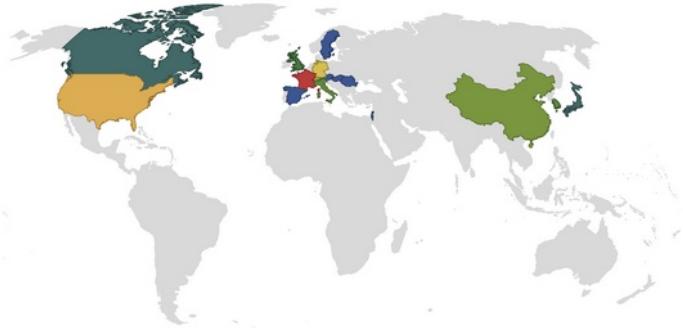
Our raison d'être

Providing solutions to issues of
EM field measurement in any
environment.



Kapteos in figures

- ◆ 14 years of experience
- ◆ A presence on 3 continents
- ◆ 100+ customers in 16 countries
- ◆ Portfolio of 8 patent families
- ◆ 145+ scientific publications
- ◆ >80% export turnover



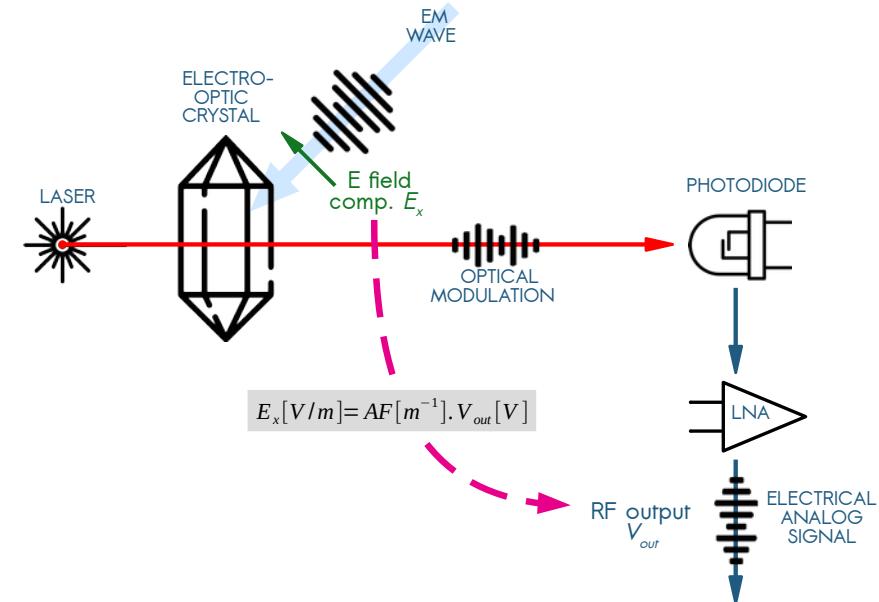
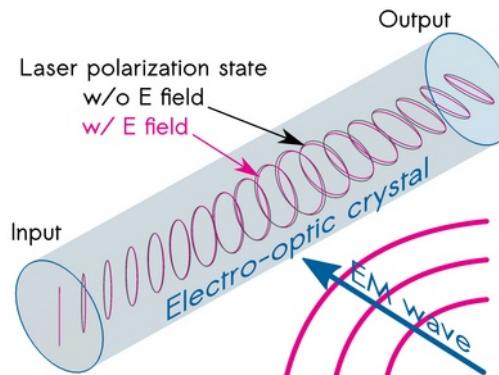


Field probe specifications

- ◆ Linear response vs field - single axis vector meas.
- ◆ Flat response vs frequency (in modulus & phase)
- ◆ Ultra high dynamic range vs field strength & freq.
- ◆ Compliant with all media (gases, liquids, plasmas...)
- ◆ No induced interference (even in near field)
- ◆ Local measurement with high spatial resolution
- ◆ Compliant with harsh environment (P, T, UV & X rays...)
- ◆ Immune to radiated & conducted disturbances
- ◆ Long distance remote measurement

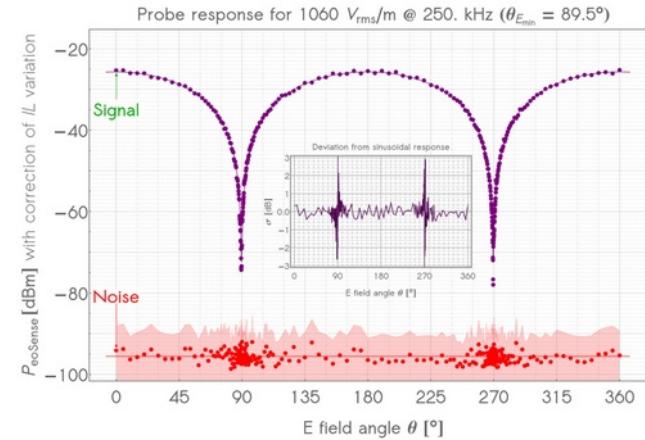
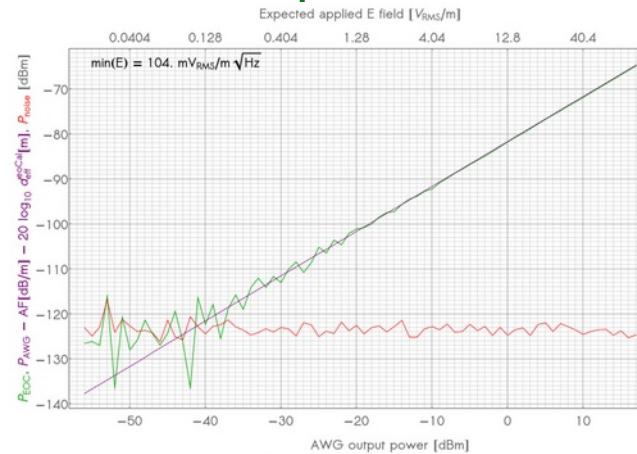
Principle of optical E-field probes

- ◆ Based on Pockels effect (1893)
 - Refractive index variation induced by E field
 - PSM (patented)



Field probe specifications: validation

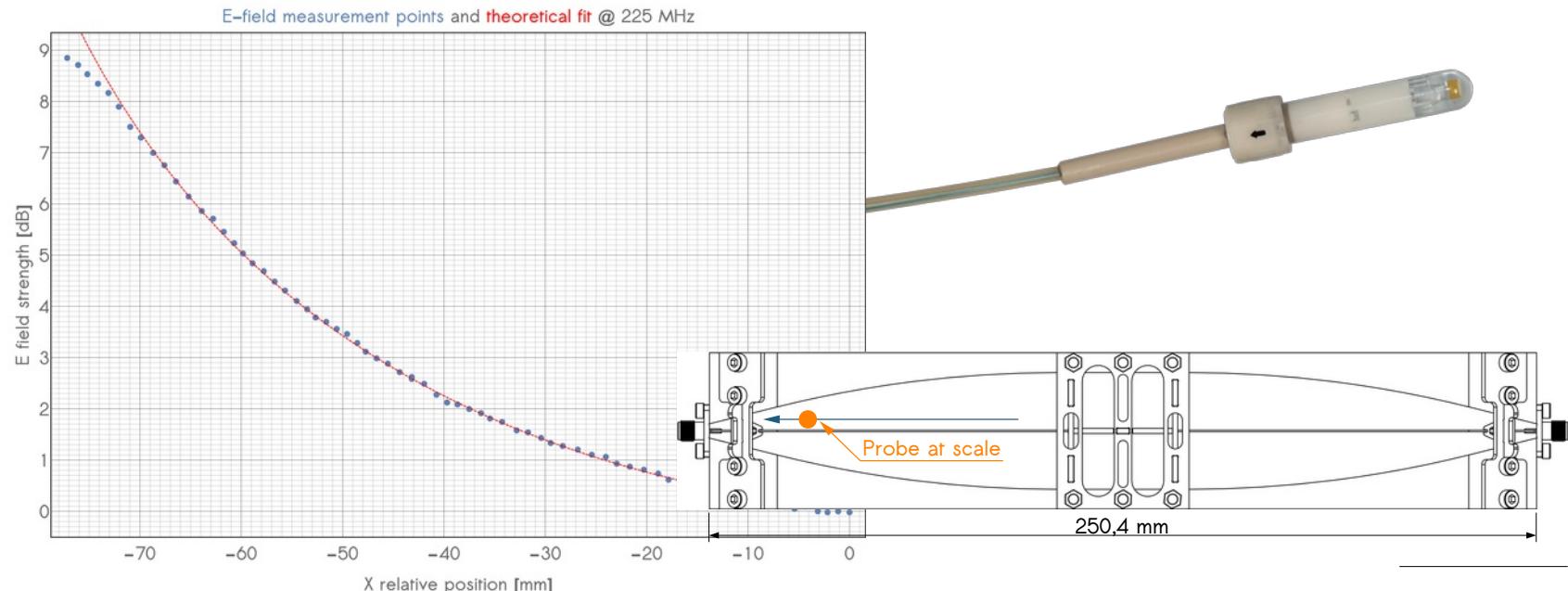
- ◆ Linear response vs field - single axis vector meas.



- ◆ Immune to radiated & conducted disturbances
- ◆ Long distance remote measurement: IL ~ 0.1 dB/km

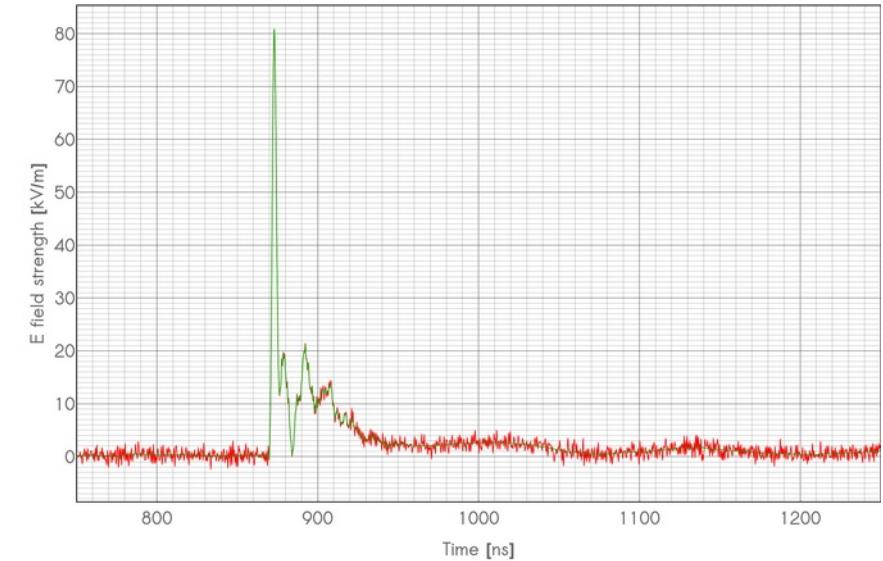
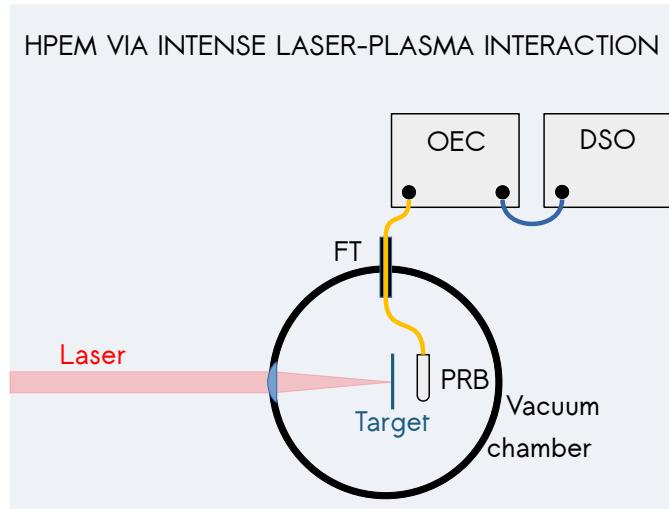
Field probe specifications: validation

- ◆ Local measurement with high spatial resolution
- ◆ No induced interference (even in near field)



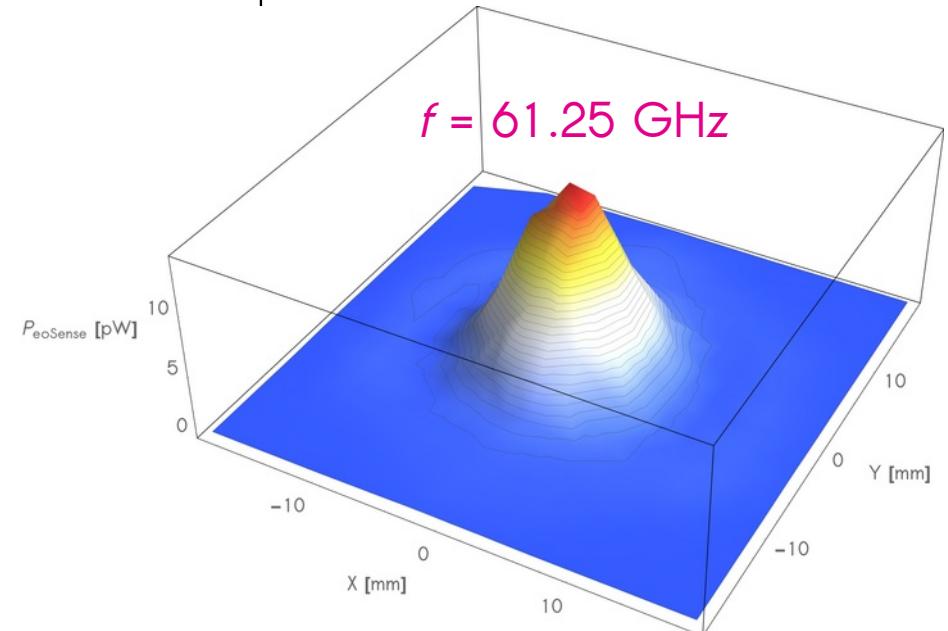
Field probe specifications: validation

- ♦ Compliant with harsh environment (P, T, UV & X rays...)
 - 5 ns laser pulse on Al target with 33.8 J (ENEA Frascati)



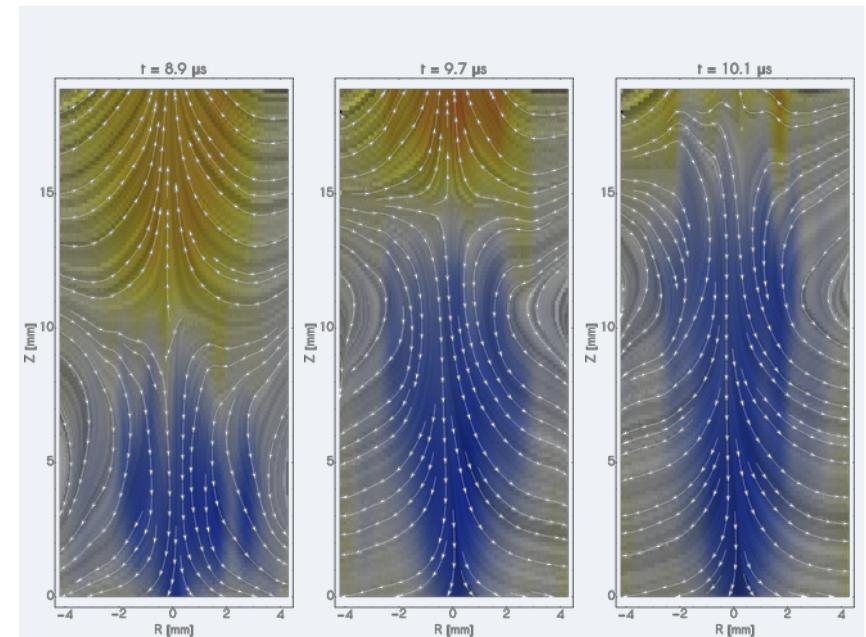
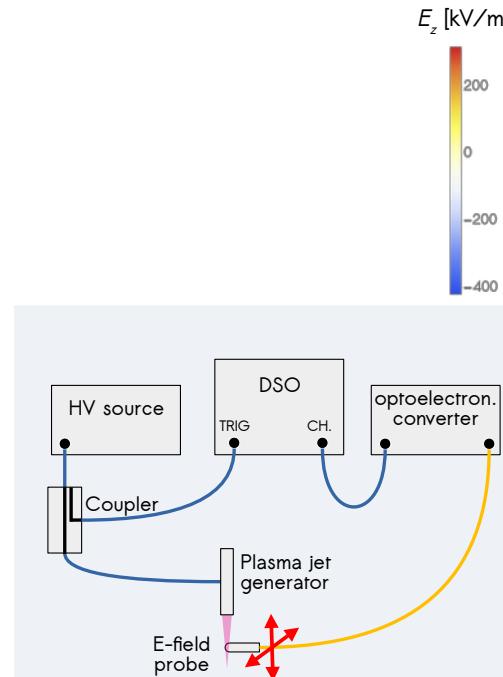
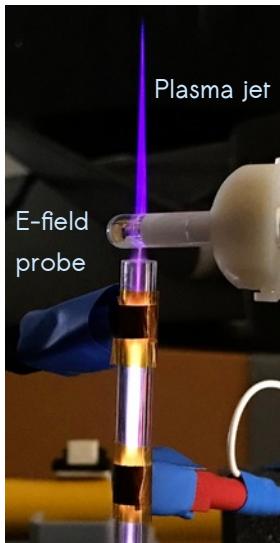
Field probe specifications: validation

- ♦ Ultra high dynamic range vs field strength & freq.
 - E-field measurement from 10 Hz up to 60+ GHz
 - Dynamic range of 130+



Field probe specifications: validation

- ♦ Compliant with all media (gases, liquids, plasmas...)



Field probe specifications: validation

- ♦ Flat response vs frequency (in modulus & phase)?
 - **Flat on 10 Hz → 500 kHz**
 - Piezoelectric resonances in the 500 kHz - 10 MHz freq. range
 - **Flat on 10 MHz → 10 GHz**
 - Mie-type diffusion effect above 10 GHz (periodically enhanced sensitivity vs frequency)

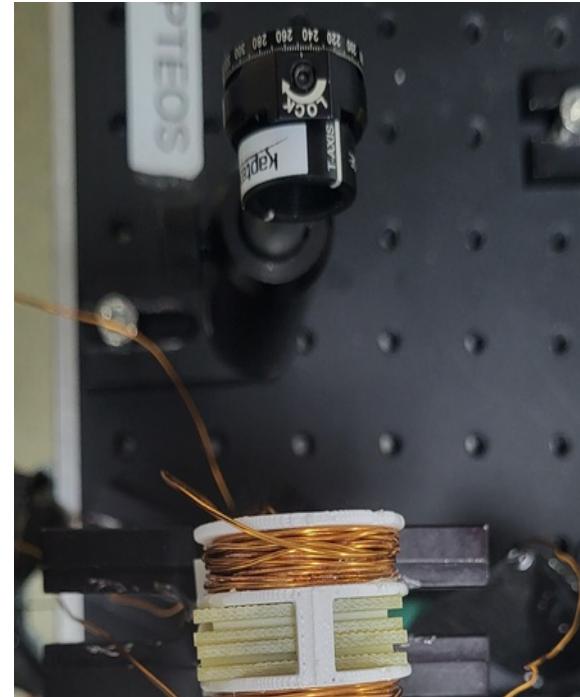
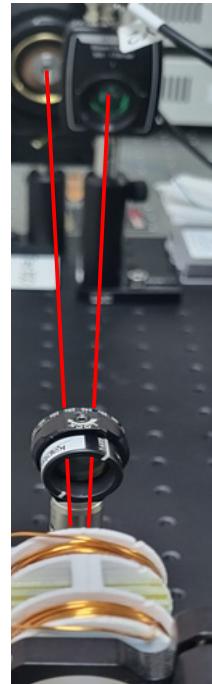


What about H field?

- ♦ Pockels effect: linear variation of n vs E_x
 - Longitudinal & transverse E-field probe
 - Pockels effect is **doubled during a forth-&-back path**
- ♦ Faraday effect: linear variation of n vs H_z
 - Longitudinal H-field probe only
 - Faraday effect is **cancelled during a forth-&-back path**

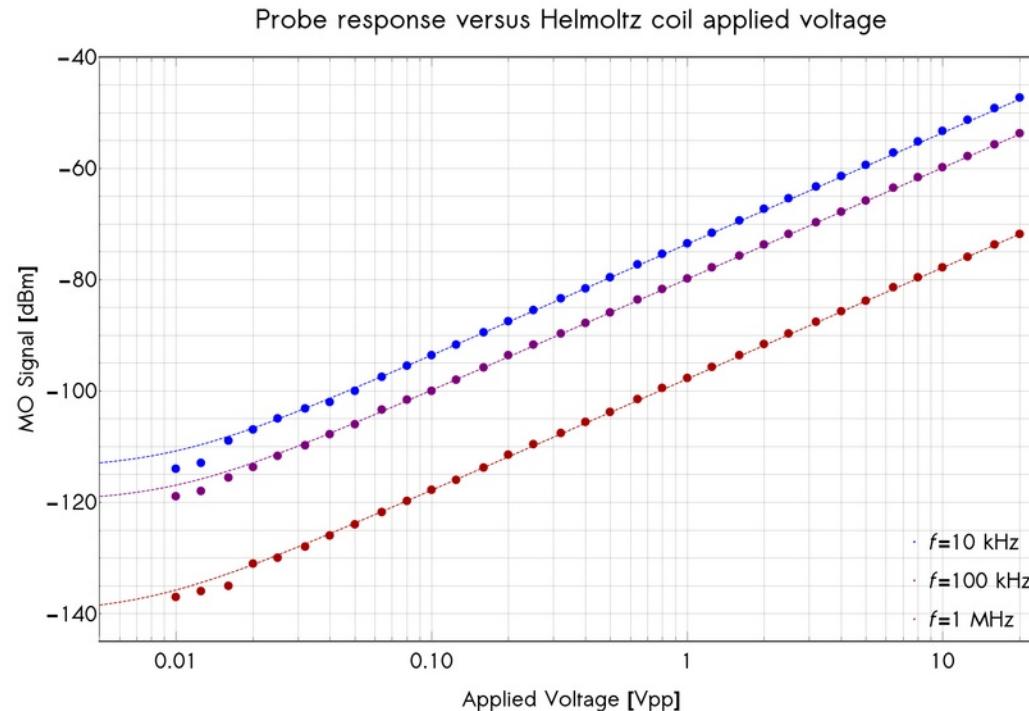
H-field probe POC

- ♦ with COTS: same forth-&-back config. as E-field probe



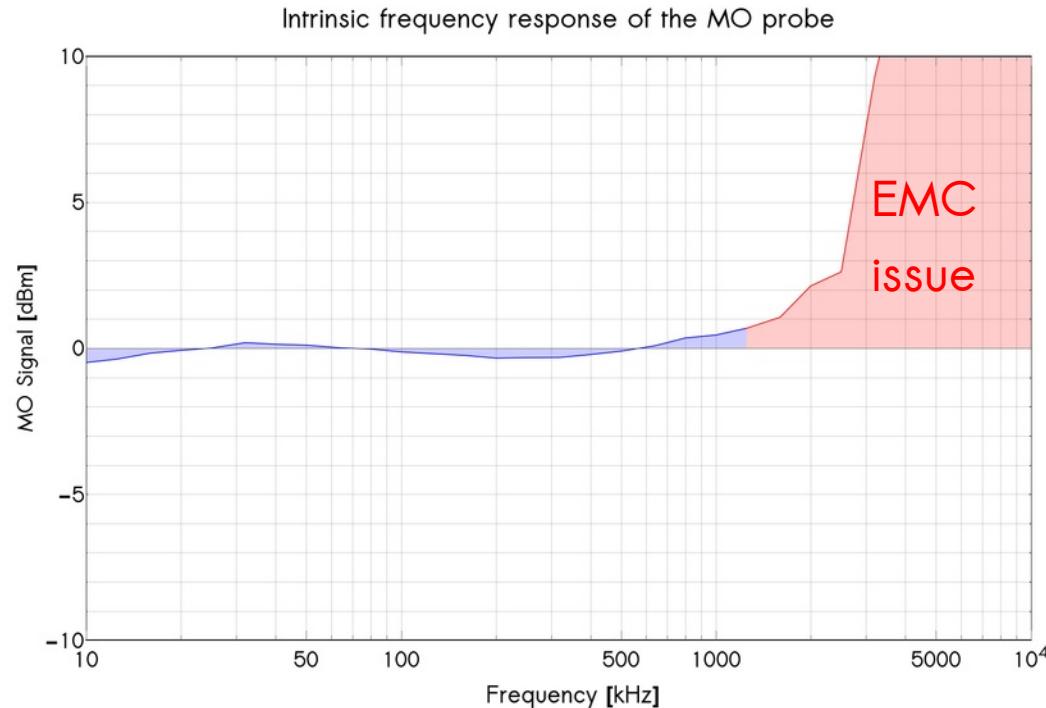
H-field probe POC

- ◆ POC response vs appl. volt. to Helmholtz coils



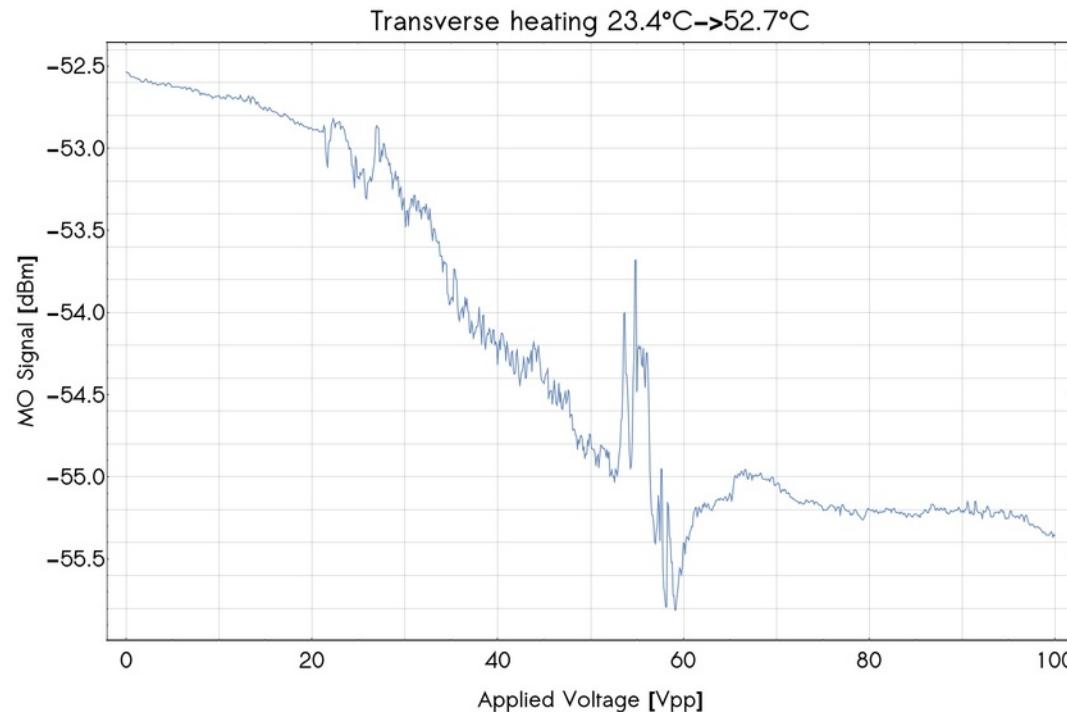
H-field probe POC

- ◆ Intrinsic POC response vs frequency



POC response vs temperature

- ♦ Acceptable variation of ~ 0.1 dB/ $^{\circ}\text{C}$



Résumé

- ♦ E-field probe
 - Freq. BW: 10 Hz → 60 GHz
 - E-field (1Hz RBW): $25 \text{ mV}_{\text{peak}}/\text{m} \rightarrow 1.4 \text{ MV}_{\text{peak}}/\text{m}$
- ♦ H-field probe
 - Freq. BW: 10 kHz → 1 MHz DC → 1 GHz expected
 - H-field (1Hz RBW): $0.025 \rightarrow 250 \text{ A}_{\text{peak}}/\text{m}$ x 200 expected
 - B-field (1Hz RBW): $0.03 \rightarrow 300 \mu\text{T}$ x 200 expected